


<b>Search Notes</b> 	<b>Application/Control No.</b> 10617349	<b>Applicant(s)/Patent Under Reexamination</b> WILLIAM ET AL.
	<b>Examiner</b> Shin, John	<b>Art Unit</b> 4132

SEARCHED			
Class	Subclass	Date	Examiner
705	Text Only: 31, 19, 36R, 417	10/03/07	JYS
705	31,19, 36R, 417	9/19/08	V.F

SEARCH NOTES		
Search Notes	Date	Examiner
EAST Search	10/03/07	JYS
West 2.0 updated	9/19/08	V.F
Updated search performed	3/12/09	V.F
Consulted With Bob Wienhardt	3/11/09	V.F
Updated search performed	7/30/09	V.F
Updated search performed	2/15/10	V.F

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
705	31, 19, 36R	2/15/10	V.F
705	417	2/15/10	V.F

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